

N-channel 50 V, 1.7 mOhm, 200 A continuous, logic level Application Specific MOSFET in LFPAK56E 26 January 2022

Product data sheet

1. General description

200 Amp continuous current, logic level gate drive, N-channel enhancement mode MOSFET in LFPAK56E package. Part of the ASFETs for Battery Isolation and DC Motor control family and using Nexperia's unique "SchottkyPlus" technology delivers high efficiency and low spiking performance usually associated with MOSFETs with an integrated Schottky or Schottky-like diode but without problematic high leakage current. The ASFET is particularly suited to 36 V battery powered applications requiring strong avalanche capability, linear mode performance, use at high switching frequencies, and also safe and reliable switching at high load-current.

2. Features and benefits

- 200 A continuous current capability
- Optimised for 36 V (nominal) battery powered applications
- LFPAK56E low-stress exposed lead-frame for ultimate reliability, optimum soldering and easy solder-joint inspection
- Copper-clip and solder die attach for low package inductance and resistance, and high ID (max) rating
- Qualified to 175 °C
- Avalanche rated, 100% tested
- Low Q_G, Q_{GD} and Q_{OSS} for high efficiency, especially at higher switching frequencies
- Superfast switching with soft body-diode recovery for low-spiking and ringing, recommended for low EMI designs
- Unique "SchottkyPlus" technology for Schottky-like switching performance and low IDSS leakage
- Narrow V_{GS(th)} rating for easy paralleling and improved current sharing
- Very strong linear-mode / safe operating area characteristics for safe and reliable switching at high-current conditions

3. Applications

- Brushless DC motor control
- Synchronous rectifier in high-power AC-to-DC applications, e.g. server power supplies
- Battery protection and Battery Management Systems (BMS)
- Load switch
- 10 cell lithium-ion battery applications (36 V 42 V)

4. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V _{DS}	drain-source voltage	25 °C ≤ T _j ≤ 175 °C		-	-	50	V
I _D	drain current	V _{GS} = 10 V; T _{mb} = 25 °C; <u>Fig. 2</u>	[1]	-	-	200	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; <u>Fig. 1</u>		-	-	333	W
Tj	junction temperature			-55	-	175	°C



Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
Static chara	acteristics			_		
R _{DSon}	drain-source on-state resistance	V _{GS} = 10 V; I _D = 25 A; T _j = 25 °C; <u>Fig. 10</u>	-	1.4	1.75	mΩ
		V _{GS} = 4.5 V; I _D = 25 A; T _j = 25 °C; <u>Fig. 10</u>	-	1.6	2	mΩ
Dynamic ch	naracteristics					
Q _{GD}	gate-drain charge	I_D = 25 A; V_{DS} = 25 V; V_{GS} = 4.5 V;	-	13	29	nC
Q _{G(tot)}	total gate charge	Fig. 12; Fig. 13	-	53	82	nC

[1] 200A Continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.

5. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S	source		
2	S	source		
3	S	source		D
4	G	gate		
mb	D	mounting base; connected to drain	LFPAK56E; Power- SO8 (SOT1023)	G LFA mbb076 S

6. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
PSMN1R5-50YLH		plastic, single-ended surface-mounted package (LFPAK56); 4 leads; 1.27 mm pitch	SOT1023

7. Marking

Table 4. Marking codes					
Type number	Marking code				
PSMN1R5-50YLH	1H550L				

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{DS}	drain-source voltage	25 °C ≤ T _j ≤ 175 °C	-	50	V
V _{DGR}	drain-gate voltage	25 °C ≤ T_j ≤ 175 °C; R_{GS} = 20 kΩ	-	50	V

PSMN1R5-50YLH

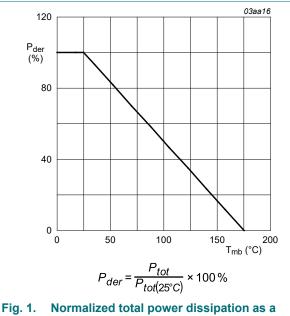
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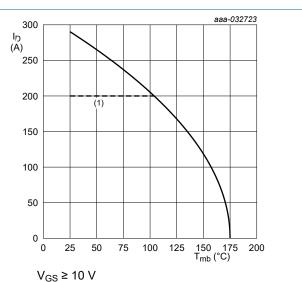
Parameter	Conditions		Min	Max	Unit
gate-source voltage			-20	20	V
total power dissipation	T _{mb} = 25 °C; <u>Fig. 1</u>		-	333	W
drain current	V _{GS} = 10 V; T _{mb} = 25 °C; <u>Fig. 2</u>	[1]	-	200	А
	V _{GS} = 10 V; T _{mb} = 100 °C; <u>Fig. 2</u>		-	200	А
peak drain current	pulsed; $t_p \le 10 \ \mu s$; $T_{mb} = 25 \ ^{\circ}C$; Fig. 3		-	1159	А
storage temperature			-55	175	°C
junction temperature			-55	175	°C
peak soldering temperature			-	260	°C
ode	1				
source current	T _{mb} = 25 °C		-	200	А
peak source current	pulsed; t _p ≤ 10 µs; T _{mb} = 25 °C		-	1159	А
jedness	1				
non-repetitive drain- source avalanche energy	$ \begin{array}{l} I_D = 50 \; A; \; V_sup \leq \; 50 \; V; \; R_GS = 50 \; \Omega; \\ V_GS = 10 \; V; \; T_{j(init)} = 25 \; ^\circC; \; unclamped; \\ t_p = 513 \; \mus \end{array} $	[2]	-	833	mJ
	I_D = 25 A; V _{sup} ≤ 50 V; R _{GS} = 50 Ω; V _{GS} = 10 V; T _{j(init)} = 25 °C; unclamped; t _p = 2.5 ms	[2]	-	2	J
non-repetitive avalanche current		[2]	-	115	A
	gate-source voltage total power dissipation drain current peak drain current storage temperature junction temperature peak soldering temperature source current peak source current gedness non-repetitive drain-source avalanche energy non-repetitive avalanche	gate-source voltage $T_{mb} = 25 \degree C; Fig. 1$ total power dissipation $T_{mb} = 25 \degree C; Fig. 1$ drain current $V_{GS} = 10 \lor; T_{mb} = 25 \degree C; Fig. 2$ $V_{GS} = 10 \lor; T_{mb} = 100 \degree C; Fig. 2$ peak drain currentpulsed; $t_p \le 10 \ \mu s; T_{mb} = 25 \degree C; Fig. 3$ storage temperaturejunction temperaturepeak solderingtemperaturesource currentpulsed; $t_p \le 10 \ \mu s; T_{mb} = 25 \degree C$ peak source currentpulsed; $t_p \le 10 \ \mu s; T_{mb} = 25 \degree C$ peak source currentpulsed; $t_p \le 10 \ \mu s; T_{mb} = 25 \degree C$ pednessnon-repetitive drain- source avalanche energy $I_D = 50 \ A; V_{sup} \le 50 \ V; \ R_{GS} = 50 \ \Omega; \ V_{GS} = 10 \ V; \ T_{j(init)} = 25 \degree C; \ unclamped; \ t_p = 513 \ \mu s$ $I_D = 25 \ A; \ V_{sup} \le 50 \ V; \ R_{GS} = 50 \ \Omega; \ V_{GS} = 10 \ V; \ T_{j(init)} = 25 \degree C; \ unclamped; \ t_p = 2.5 \ ms$ non-repetitive avalancheNon-repetitive avalancheV_{sup} \le 50 \ V; \ V_{GS} = 10 \ V; \ T_{j(init)} = 25 \degree C; \ unclamped; \ t_p = 2.5 \ ms	$ \begin{array}{ c c c c } \hline gate-source voltage & & & & & & \\ \hline total power dissipation & T_{mb} = 25 \ ^{\circ}C; \ Fig. 1 & & & & \\ \hline drain current & V_{GS} = 10 \ ^{\circ}V; \ T_{mb} = 25 \ ^{\circ}C; \ Fig. 2 & & & \\ \hline V_{GS} = 10 \ ^{\circ}V; \ T_{mb} = 100 \ ^{\circ}C; \ Fig. 2 & & \\ \hline Peak drain current & pulsed; \ t_p \leq 10 \ ^{\circ}Js; \ ^{\circ}T_{mb} = 25 \ ^{\circ}C; \ Fig. 3 & & \\ \hline storage temperature & & & & \\ \hline junction temperature & & & & \\ \hline peak soldering \\ temperature & & & & \\ \hline node & & & \\ \hline source current & T_{mb} = 25 \ ^{\circ}C & & & \\ \hline peak source current & pulsed; \ t_p \leq 10 \ ^{\circ}Js; \ T_{mb} = 25 \ ^{\circ}C & & \\ \hline peak source current & pulsed; \ t_p \leq 10 \ ^{\circ}Js; \ T_{mb} = 25 \ ^{\circ}C & & \\ \hline peat source avalanche energy & \begin{matrix} I_D = 50 \ ^{\circ}A; \ ^{\circ}V_{SG} = 10 \ ^{\circ}Y; \ ^{\circ}J_{(init)} = 25 \ ^{\circ}C; \ unclamped; \ t_p = 513 \ ^{\circ}Js & & \\ \hline I_D = 25 \ ^{\circ}Y; \ ^{\circ}Js = 10 \ ^{\circ}Y; \ ^{\circ}J_{(init)} = 25 \ ^{\circ}C; \ unclamped; \ t_p = 2.5 \ ms & \\ \hline non-repetitive avalanche & V_{sup} \leq 50 \ ^{\circ}Y; \ V_{GS} = 10 \ ^{\circ}Y; \ T_{j(init)} = 25 \ ^{\circ}C; \ unclamped; \ t_p = 2.5 \ ms & \\ \hline non-repetitive avalanche & V_{sup} \leq 50 \ ^{\circ}Y; \ V_{GS} = 10 \ ^{\circ}Y; \ T_{j(init)} = 25 \ ^{\circ}C; \ (2) & \\ \hline \end{array}$	$ \begin{array}{ c c c c } gate-source voltage & -20 \\ \hline total power dissipation & T_{mb} = 25 °C; Fig. 1 & - \\ \hline & V_{GS} = 10 V; T_{mb} = 25 °C; Fig. 2 & [1] & - \\ \hline & V_{GS} = 10 V; T_{mb} = 100 °C; Fig. 2 & - \\ \hline & $peak drain current & $pulsed; $t_p \leq 10 \ \mu s; T_{mb} = 25 °C; Fig. 3 & - \\ \hline & $torage temperature & -55 \\ \hline & $junction temperature & -55 \\ \hline & $peak soldering \\ temperature & & -55 \\ \hline & $peak soldering \\ temperature & & & -55 \\ \hline & $peak source current & T_{mb} = 25 °C & & - \\ \hline & $peak source current & T_{mb} = 25 °C & & & - \\ \hline & $peak source current & $pulsed; $t_p \leq 10 \ \mu s; T_{mb} = 25 °C & & & - \\ \hline & $peak source current & $pulsed; $t_p \leq 10 \ \mu s; T_{mb} = 25 °C & & & - \\ \hline & $peak source current & $pulsed; $t_p \leq 10 \ \mu s; T_{mb} = 25 °C & & & - \\ \hline & $peak source current & $pulsed; $t_p \leq 10 \ \mu s; T_{mb} = 25 °C & & & - \\ \hline & $peak source current & $pulsed; $t_p \leq 10 \ \mu s; T_{mb} = 25 °C & & & - \\ \hline & $peak source avalanche energy \\ \hline & I_D = 50 \ A; V_{sup} \leq 50 \ V; R_{GS} = 50 \ \Omega; \\ V_{GS} = 10 \ V; $T_{j(init)}$ = 25 °C; $unclamped; t_p = 513 \ \mu s & \\ \hline & I_D = 25 \ A; V_{sup} \leq 50 \ V; R_{GS} = 50 \ \Omega; \\ V_{GS} = 10 \ V; $T_{j(init)}$ = 25 °C; $unclamped; t_p = 2.5 ms & \\ \hline & $non-repetitive avalanche V_{sup} \leq 50 \ V; V_{GS} = 10 \ V; $T_{j(init)}$ = 25 °C; $unclamped; t_p = 2.5 ms & \\ \hline & $non-repetitive avalanche V_{sup} \leq 50 \ V; V_{GS} = 10 \ V; $T_{j(init)}$ = 25 °C; $unclamped; t_p = 2.5 ms & \\ \hline & $non-repetitive avalanche V_{sup} \leq 50 \ V; V_{GS} = 10 \ V; $T_{j(init)}$ = 25 °C; $unclamped; t_p = 2.5 ms & \\ \hline & $non-repetitive avalanche V_{sup} \leq 50 \ V; V_{GS} = 10 \ V; $T_{j(init)}$ = 25 °C; $unclamped; t_p = 2.5 ms & \\ \hline & $non-repetitive avalanche V_{sup} \leq 50 \ V; V_{GS} = 10 \ V; $T_{j(init)}$ = 25 °C; $unclamped; V_{SU} = U_{SU} = $U_{SU}$$	$ \begin{array}{ c c c c c } gate-source voltage & -20 & 20 \\ \hline total power dissipation & T_{mb} = 25 °C; Fig. 1 & - & 333 \\ \hline drain current & V_{GS} = 10 V; T_{mb} = 25 °C; Fig. 2 & [1] & - & 200 \\ \hline V_{GS} = 10 V; T_{mb} = 100 °C; Fig. 2 & - & 200 \\ \hline v_{GS} = 10 V; T_{mb} = 100 °C; Fig. 2 & - & 200 \\ \hline $peak drain current & $pulsed; t_p \le 10 μ; T_{mb} = 25 °C; Fig. 3 & - & 1159 \\ \hline $storage temperature & -55 & 175 \\ \hline $junction temperature & -55 & 175 \\ \hline $peak soldering \\ temperature & -55 & 175 \\ \hline $peak soldering \\ temperature & - & - & 260 \\ \hline $peak source current & T_{mb} = 25 °C & - & 200 \\ \hline $peak source current & $pulsed; t_p \le 10 μ; T_{mb} = 25 °C & - & 1159 \\ \hline $peak source current & $pulsed; t_p \le 10 μ; T_{mb} = 25 °C & - & 1159 \\ \hline $peak source avalanche energy $ V_{GS}$ = 10 V; $T_{j(init)}$ = 25 °C; $unclamped; t_p = 513 μs $ \\ \hline l_D = 25 A; V_{sup} \le 50 V; R_{GS} = 50 Ω; V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; $unclamped; t_p = 2.5 $ms $ \\ \hline $non-repetitive avalanche V_{sup} \le 50 V; V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; $unclamped; t_p = 2.5 $ms $ \\ \hline $non-repetitive avalanche V_{sup} \le 50 V; V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; $unclamped; t_p = 2.5 $ms $ \\ \hline $non-repetitive avalanche V_{sup} \le 50 V; V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; $unclamped; t_p = 2.5 $ms $ \\ \hline $non-repetitive avalanche V_{sup} \le 50 V; V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; $unclamped; t_p = 2.5 $ms $ \\ \hline $non-repetitive avalanche V_{sup} \le 50 V; V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; $unclamped; t_p = 2.5 $ms $ \\ \hline $non-repetitive avalanche V_{sup} \le 50 V; V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; $unclamped; t_p = 2.5 $ms $ \\ \hline $non-repetitive avalanche V_{sup} \le 50 V; V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; $Unclamped; t_p = 2.5 $ms $ \\ \hline $non-repetitive avalanche V_{sup} \le 50 V; V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; $Unclamped; T_{SU} $ \\ \hline $non-repetitive avalanche V_{sup} \le 50 V; V_{GS} = 10 V; $$

[1] 200A Continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.

[2] Protected by 100% test

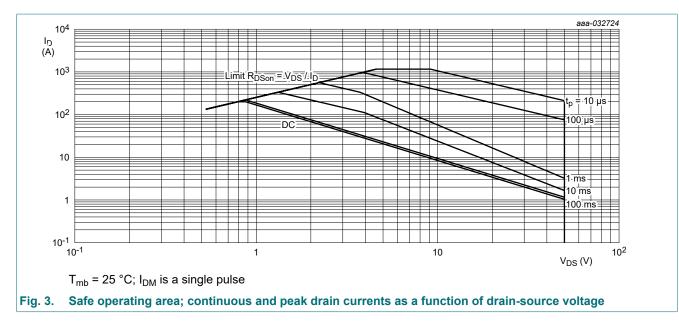






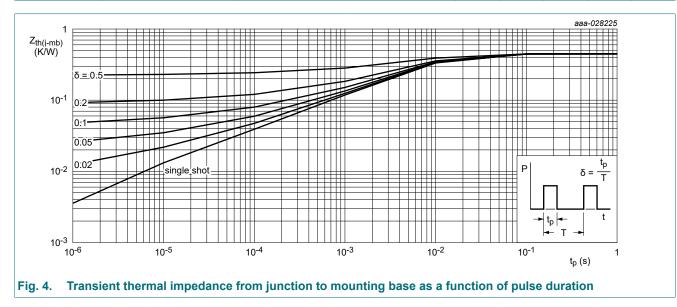
(1) 200A continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.

Fig. 2. Continuous drain current as a function of mounting base temperature

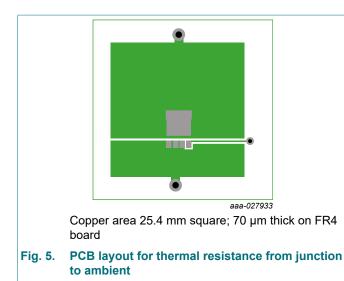


9. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base	Fig. <u>4</u>	-	0.33	0.45	K/W
R _{th(j-a)}	thermal resistance from	Fig. 5	-	42	-	K/W
	junction to ambient	Fig. 6	-	85	-	K/W



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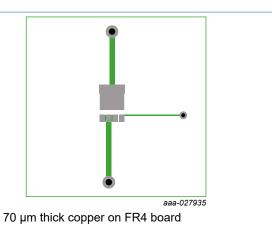


Fig. 6. PCB layout with minimum footprint for thermal resistance from junction to ambient

10. Characteristics

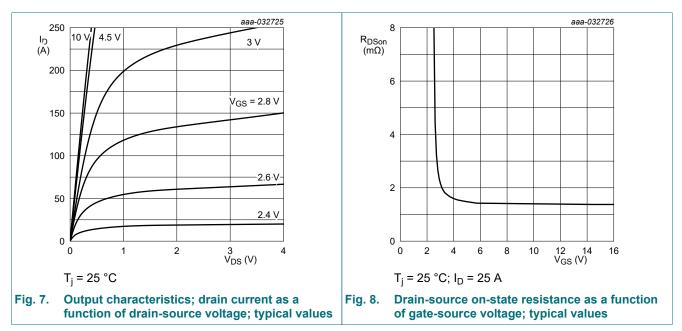
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static charac	teristics					
V _{(BR)DSS}	drain-source	I _D = 250 μA; V _{GS} = 0 V; T _j = 25 °C	50	-	-	V
	breakdown voltage	I _D = 250 μA; V _{GS} = 0 V; T _j = -55 °C	45	-	-	V
V _{GS(th)}	gate-source threshold voltage	I _D = 1 mA; V _{DS} =V _{GS} ; T _j = 25 °C	1.2	1.61	2.2	V
$\Delta V_{GS(th)} / \Delta T$	gate-source threshold voltage variation with temperature	25 °C ≤ T _j ≤ 150 °C	-	-4.6	-	mV/K
I _{DSS}	drain leakage current	V _{DS} = 40 V; V _{GS} = 0 V; T _j = 25 °C	-	0.01	1	μA
		V _{DS} = 40 V; V _{GS} = 0 V; T _j = 125 °C	-	3.9	-	μA
I _{GSS}	gate leakage current	V _{GS} = 16 V; V _{DS} = 0 V; T _j = 25 °C	-	2	100	nA
		V _{GS} = -16 V; V _{DS} = 0 V; T _j = 25 °C	-	2	100	nA
R _{DSon}	drain-source on-state resistance	V _{GS} = 10 V; I _D = 25 A; T _j = 25 °C; Fig. 10	-	1.4	1.75	mΩ
		V _{GS} = 10 V; I _D = 25 A; T _j = 150 °C; <u>Fig. 11</u>	-	-	3.52	mΩ
		V _{GS} = 4.5 V; I _D = 25 A; T _j = 25 °C; Fig. 10	-	1.6	2	mΩ
		V _{GS} = 4.5 V; I _D = 25 A; T _j = 150 °C; Fig. 11	-	-	4.02	mΩ
R _G	gate resistance	f = 1 MHz; T _j = 25 °C	0.52	1.3	3.3	Ω
Dynamic cha	racteristics					
Q _{G(tot)}	total gate charge	I_D = 25 A; V_{DS} = 25 V; V_{GS} = 4.5 V; Fig. 12; Fig. 13	-	53	82	nC
		I_D = 25 A; V_{DS} = 25 V; V_{GS} = 10 V; Fig. 12; Fig. 13	-	117	181	nC
		I _D = 0 A; V _{DS} = 0 V; V _{GS} = 10 V	-	61	-	nC

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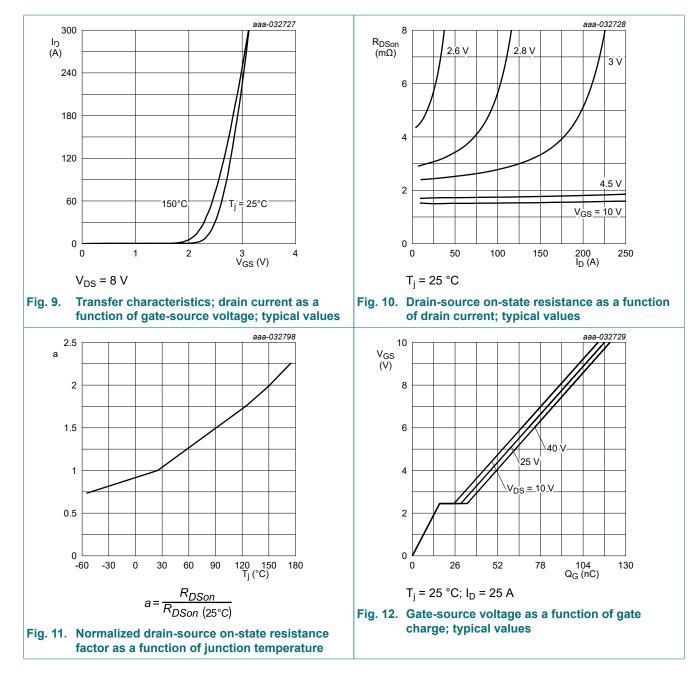
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Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Q _{GS}	gate-source charge	I _D = 25 A; V _{DS} = 25 V; V _{GS} = 4.5 V;		-	17	26	nC
Q _{GS(th)}	pre-threshold gate- source charge	Fig. 12; Fig. 13		-	11.3	17	nC
Q _{GS(th-pl)}	post-threshold gate- source charge			-	5.4	8	nC
Q _{GD}	gate-drain charge	F		-	13	29	nC
V _{GS(pl)}	gate-source plateau voltage	I _D = 25 A; V _{DS} = 25 V; <u>Fig. 12; Fig. 13</u>		-	2.5	-	V
C _{iss}	input capacitance	V _{DS} = 25 V; V _{GS} = 0 V; f = 1 MHz;		-	7959	11143	pF
C _{oss}	output capacitance	_ T _j = 25 °C; <u>Fig. 14</u>		-	799	1119	pF
C _{rss}	reverse transfer capacitance			-	231	554	pF
t _{d(on)}	turn-on delay time	$V_{DS} = 25 \text{ V}; \text{ R}_{L} = 1 \Omega; \text{ V}_{GS} = 4.5 \text{ V};$		-	39	-	ns
t _r	rise time	$R_{G(ext)} = 5 \Omega$		-	40	-	ns
t _{d(off)}	turn-off delay time			-	68	-	ns
t _f	fall time			-	32	-	ns
Q _{oss}	output charge	V _{GS} = 0 V; V _{DS} = 25 V; f = 1 MHz; T _j = 25 °C		-	42	-	nC
Source-drai	in diode	1					
V _{SD}	source-drain voltage	I _S = 25 A; V _{GS} = 0 V; T _j = 25 °C; <u>Fig. 15</u>		-	0.75	1	V
t _{rr}	reverse recovery time	$I_{S} = 25 \text{ A}; \text{ d}I_{S}/\text{d}t = -100 \text{ A}/\mu\text{s}; \text{ V}_{GS} = 0 \text{ V};$		-	36	-	ns
Q _r	recovered charge	V _{DS} = 25 V; <u>Fig. 16</u>	[1]	-	37	-	nC
t _a	reverse recovery rise time			-	21	-	ns
t _b	reverse recovery fall time			-	14	-	ns

[1] includes capacitive recovery

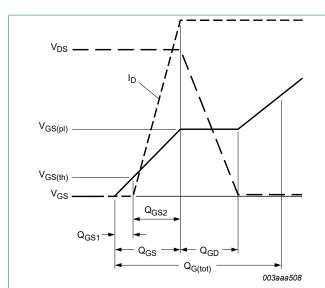


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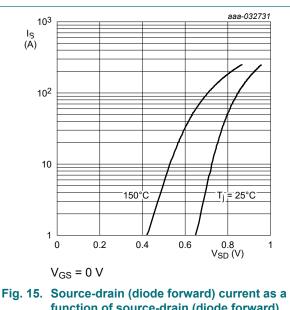


Product data sheet

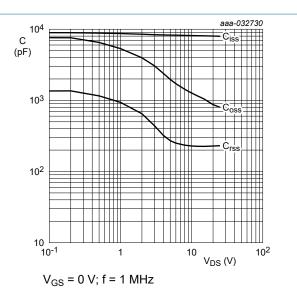
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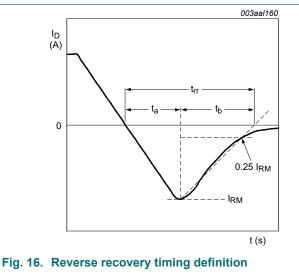






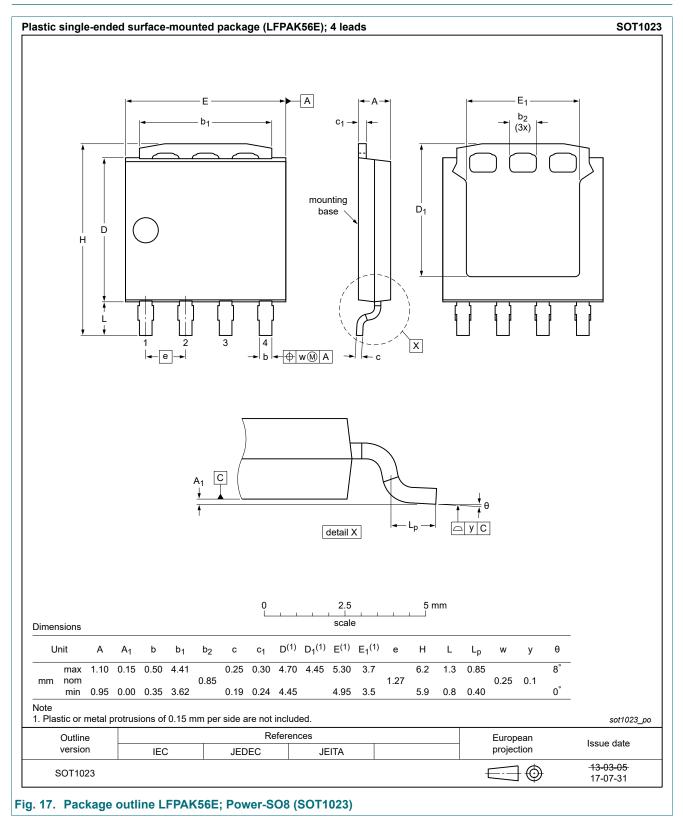




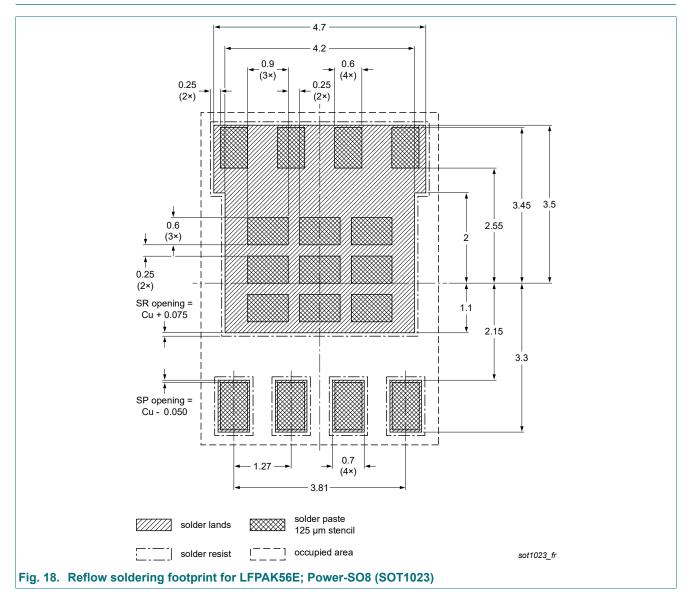


PSMN1R5-50YLH

11. Package outline



12. Soldering



Product data sheet

13. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

 Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the internet at <u>https://www.nexperia.com</u>.

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